


<b>Search Notes</b> 	<b>Application/Control No.</b> 10790728	<b>Applicant(s)/Patent Under Reexamination</b> HAN, CHEUL KYUNG
	<b>Examiner</b> LINH T NGUYEN	<b>Art Unit</b> 2627

SEARCHED			
Class	Subclass	Date	Examiner
369	47.53, 116	2/25/2009	LN

SEARCH NOTES		
Search Notes	Date	Examiner
Update searched on East.	2/25/2009	LN
Interference searched on East ".clm."	2/25/2009	LN
Searched on IBM, JPO, EPO, DERWENT, USOCR, FPRS	2/25/2009	LN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Print out searched history.	2/25/2009	LN

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